

**Notice of References Cited**

Application/Control No.

09/538,339

Applicant(s)/Patent Under  
Reexamination  
NANBA ET AL.

Examiner

Javid A Amini

Art Unit

2672

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,266,113 B1	07-2001	Yamazaki et al.	349/115
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	EDN Magazine, Design Ideas, <a href="http://www.reed-electronics.com/ednmag/archives/1997/121897/26di_04.htm#Figure%201;">http://www.reed-electronics.com/ednmag/archives/1997/121897/26di_04.htm#Figure%201;</a> December 18, 1997, pp 1-4.
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